


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567183	<b>Applicant(s)/Patent Under Reexamination</b>  TSURUKAWA ET AL.
	<b>Examiner</b>  Mark Spisich	<b>Art Unit</b>  3727

SEARCHED			
Class	Subclass	Date	Examiner
15	167.1	7/13/2009	MS
15	172	7/13/2009	MS
15	206	7/13/2009	MS
132	321	7/13/2009	MS
132	329	7/13/2009	MS
433	141	7/13/2009	MS

SEARCH NOTES			
Search Notes		Date	Examiner
searched EASt in IPC A61C 15/00,02 and A46B 7/02,3/18,9/04,10 (ALL)		7/13/2009	MS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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